



## **Technical Features:**

Experiment for measurement of Hall Coefficient in semiconductors such Germanium with both n anP type samples.

The setup should consist of:

1.Two Hall Probe (Ge Crystal) n-type and p-type one each. Ge single crystal with four spring-type pressure contacts. Four leads for connecting measuring devices

Resistivity: up to 20 ohm.cm. Zero-field potential: <1mV. Hall Voltage: 25-35mV/10mA/KG

- 2.Hall Effect Set-up should consist of Millivoltmeter and Constant Current Source. Millivoltmeter of 0-200mV. Accuracy: ±0.1% Constant Current Power Supply of range 0-20mA, resolution 10µA, with Load and Line regulation
- 3.Computer Interface: An interface enabling the user to operate the hall effect setup through a computer. The interface is attached to any USB port and on activation a GUI shows the computer control, data storage and graph plotting of the experiment. Also included is the option for automatic computation of hall coefficient, carrier mobility and carrier density.

- 4.Electromagnet with 50mm pole dia, Low Carbon steel, Two coils with 900 turns each. Magnetic field strength variable upto 7.5 KG.
- 5.Constant Current Power Supply for above electromagnet (0-4A current) continuously variable. Complete unit housed in metal cabinet with effective electromagnetic shielding.
- 6. Digital Gaussmeter with GaAs Transverse Probe. Range: 0-2KG, 0-20KG and 7 segment LED display with accuracy 0.5%. Complete unit housed in metal cabinet with effective electromagnetic shielding. With USB interface. Can be connected directly to window-based PC, Complete with software.

Photographs are for reference only final product may vary

**MANUFACTURED BY:** 

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